

#### **FEATURES**

- Controlled Baseline
  - One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of up to –55°C to 125°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree (1)
- 4.5-V to 5.5-V V<sub>CC</sub> Operation
- Inputs Accept Voltages to 5.5 V
- Max t<sub>pd</sub> of 9.5 ns at 5 V
- Inputs Are TTL Compatible
- (1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

#### DW OR NS PACKAGE (TOP VIEW) 20 V<sub>CC</sub> 1<del>OE</del> 1A1 **∏**2 19**∏** 2<del>OE</del> 2Y4 **1**3 18**∏** 1Y1 1A2 [ 17 П 2А4 2Y3 15 16 1 1Y2 1A3 **∏** 6 15**∏** 2A3 2Y2 [ 14**∏** 1Y3 1A4 **∏**8 13**∏** 2A2 2Y1 ¶9 12**∏** 1Y4 **GND** 10 🛮 2A1

### **DESCRIPTION/ORDERING INFORMATION**

The SN74ACT244-EP octal buffer/driver is designed specifically to improve the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented receivers and transmitters.

The device is organized as two 4-bit buffers/drivers with separate output-enable  $(\overline{OE})$  inputs. When  $\overline{OE}$  is low, the device passes noninverted data from the A inputs to the Y outputs. When  $\overline{OE}$  is high, the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

### **ORDERING INFORMATION**

T <sub>A</sub>	PA	CKAGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
-55°C to 125°C	SOIC - DW	Tape and reel	SN74ACT244MDWREP	SACT244MEP	
	SOP - NS	Tape and reel	SN74ACT244MNSREP	SACT244MEP	
–40°C to 85°C	SOIC - DW	Tape and reel	SN74ACT244IDWREP	SACT244IEP	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

# FUNCTION TABLE (EACH BUFFER)

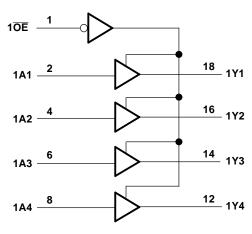
INPU	OUTPUT	
ŌĒ	Α	Y
L	Н	Н
L	L	L
Н	Χ	Z

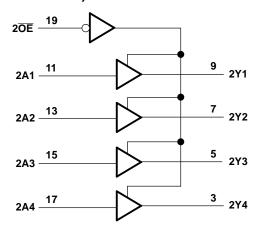


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### **LOGIC DIAGRAM (POSITIVE LOGIC)**





### Absolute Maximum Ratings(1)

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
$V_{CC}$	Supply voltage range		-0.5	7	V
VI	Input voltage range <sup>(2)</sup>				V
Vo	Output voltage range <sup>(2)</sup>		-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	$V_I < 0$ or $V_I > V_{CC}$		±20	mA
I <sub>OK</sub>	Output clamp current $V_O < 0 \text{ or } V_O > V_{CC}$			±20	mA
Io	Continuous output current	$V_O = 0$ to $V_{CC}$		±50	mA
	Continuous current through V <sub>CC</sub> or GND			±200	mA
0	Package thermal impedance (3)	DW package		58	°C/W
$\theta_{JA}$	Fackage thermal impedance (5)	NS package		60	C/VV
T <sub>stg</sub>	Storage temperature range (4)	·	-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### Recommended Operating Conditions<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage	4.5	5.5	V	
V <sub>IH</sub>	High-level input voltage		2		V
V <sub>IL</sub>	Low-level input voltage		0.8	V	
$V_{I}$	Input voltage	0	$V_{CC}$	V	
Vo	Output voltage	0	$V_{CC}$	V	
I <sub>OH</sub>	High-level output current			-24	mA
I <sub>OL</sub>	Low-level output current			24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate			8	ns/V
_	Operating free cir temperature	SN74ACT244M-EP	-55	125	۰۵
T <sub>A</sub>	Operating free-air temperature	SN74ACT244I-EP	-40	85	°C

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

<sup>(2)</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>(3)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

<sup>(4)</sup> Long-term high-temperature storage and/or extended use at maximum recommended operating conditions may result in a reduction of overall device life. See http://www.ti.com/ep\_quality for additional information on enhanced plastic packaging.



### SN74ACT244-EP OCTAL BUFFER/DRIVER WITH 3-STATE OUTPUTS

### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V	T	<sub>A</sub> = 25°C		SN74ACT24	44M-EP	SN74ACT2	44I-EP	UNIT	
PARAMETER	TEST CONDITIONS	V <sub>CC</sub>	MIN	TYP	MAX	MIN	MAX	MIN	MAX		
	I 50 A	4.5 V	4.4	4.49		4.4		4.4			
	$I_{OH} = -50 \mu A$	5.5 V	5.4	5.49		5.4		5.4			
V <sub>OH</sub>	1 24 m A	4.5 V	3.86			3.7		3.76		V	
	$I_{OH} = -24 \text{ mA}$	5.5 V	4.86			4.7		4.76			
	$I_{OH} = -75 \text{ mA}^{(1)}$	5.5 V						3.85			
	I 50 A	4.5 V		0.001	0.1		0.1		0.1		
	I <sub>OL</sub> = 50 μA	5.5 V		0.001	0.1		0.1		0.1		
$V_{OL}$		4.5 V			0.36		0.5		0.44	V	
	$I_{OL} = 24 \text{ mA}$	5.5 V			0.36		0.5		0.44		
	I <sub>OL</sub> = 75 mA <sup>(1)</sup>	5.5 V							1.65		
I <sub>OZ</sub>	$V_O = V_{CC}$ or GND	5.5 V			±0.25		±5		±2.5	μΑ	
l <sub>l</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5.5 V			±0.1		±1		±1	μΑ	
I <sub>CC</sub>	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		80		40	μΑ	
ΔI <sub>CC</sub> <sup>(2)</sup>	One input at 3.4 V, Other inputs at GND or V <sub>CC</sub>	5.5 V		0.6			1.6		1.5	mA	
C <sub>i</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		2.5						pF	
C <sub>o</sub>	V <sub>I</sub> = V <sub>CC</sub> or GND	5 V		8						pF	

<sup>(1)</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 2 ms.

### **Switching Characteristics**

over recommended operating free-air temperature range,  $V_{CC}$  = 5 V  $\pm$  0.5 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	$T_A = 25^{\circ}C$			SN74ACT24	4M-EP	SN74ACT244I-EP		UNIT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNII
t <sub>PLH</sub>	А	V	2	6.5	9	1	10	1.5	10	ne
t <sub>PHL</sub>		Ť	2	7	9	1	10	1.5	10	ns
t <sub>PZH</sub>	<u>OE</u>	V	1.5	7	8.5	1	9.5	1	9.5	20
t <sub>PZL</sub>	OE	Y	2	7	9.5	1	11	1.5	10.5	ns
t <sub>PHZ</sub>	ŌĒ	OE V	2	8	9.5	1	11	1.5	10.5	20
t <sub>PLZ</sub>		T	2.5	7.5	10	1	11.5	2	10.5	ns

### **Operating Characteristics**

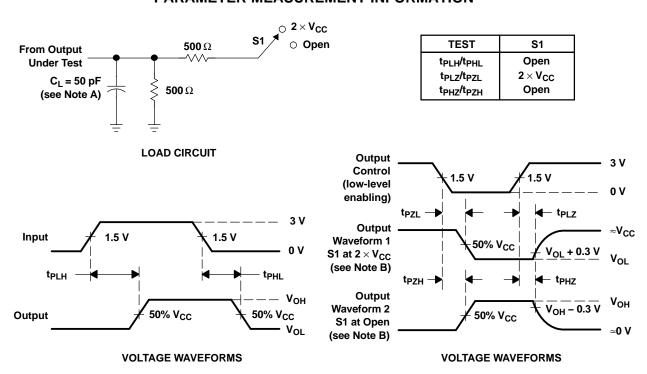
 $V_{CC} = 5 \text{ V}, T_A = 25^{\circ}\text{C}$ 

	PARAMETER	TEST CO	TYP	UNIT	
$C_{pd}$	Power dissipation capacitance	$C_L = 50 pF$ ,	f = 1 MHz	45	pF

<sup>2)</sup> This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or V<sub>CC</sub>.



### PARAMETER MEASUREMENT INFORMATION



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz,  $Z_O = 50 \Omega$ ,  $t_r \leq$  2.5 ns,  $t_f \leq$  2.5 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

www.ti.com 11-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/	MSL rating/	Op temp (°C)	Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
SN74ACT244IDWREP	Active	Production	SOIC (DW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SACT244IEP
SN74ACT244IDWREP.A	Active	Production	SOIC (DW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SACT244IEP
SN74ACT244MDWREP	Last	Production	SOIC (DW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	SACT244MEP
	Time Buy								
SN74ACT244MNSREP	Active	Production	SOP (NS)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	SACT244MEP
SN74ACT244MNSREP.A	Active	Production	SOP (NS)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	SACT244MEP
V62/04620-01XE	Last	Production	SOIC (DW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	SACT244MEP
	Time Buy								
V62/04620-01YE	Active	Production	SOP (NS)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-55 to 125	SACT244MEP
V62/04620-02XE	Active	Production	SOIC (DW)   20	2000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 85	SACT244IEP

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.



### PACKAGE OPTION ADDENDUM

www.ti.com 11-Nov-2025

and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF SN74ACT244-EP:

Catalog: SN74ACT244

Automotive: SN74ACT244-Q1

Military: SN54ACT244

NOTE: Qualified Version Definitions:

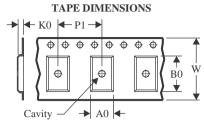
- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects
- Military QML certified for Military and Defense Applications

### **PACKAGE MATERIALS INFORMATION**

www.ti.com 24-Jul-2025

### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

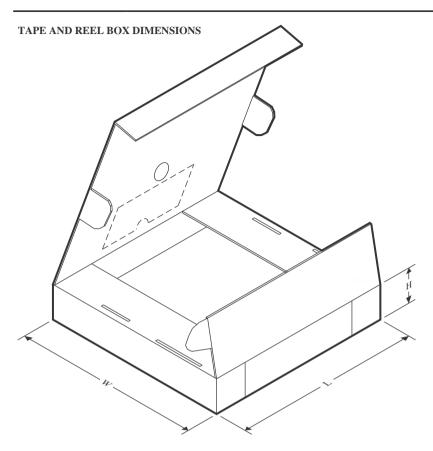
### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74ACT244IDWREP	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74ACT244MDWREP	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74ACT244MNSREP	SOP	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1

www.ti.com 24-Jul-2025

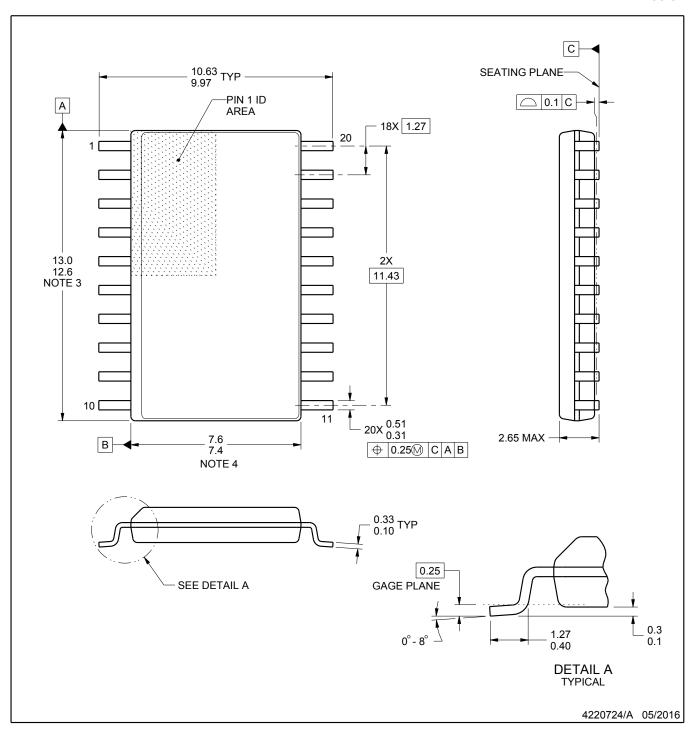


### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74ACT244IDWREP	SOIC	DW	20	2000	356.0	356.0	45.0
SN74ACT244MDWREP	SOIC	DW	20	2000	356.0	356.0	45.0
SN74ACT244MNSREP	SOP	NS	20	2000	356.0	356.0	45.0



SOIC



#### NOTES:

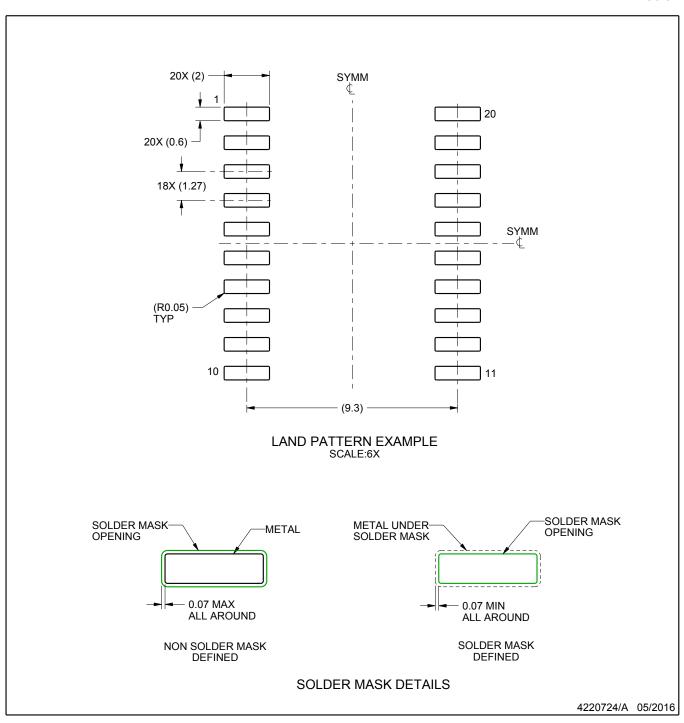
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



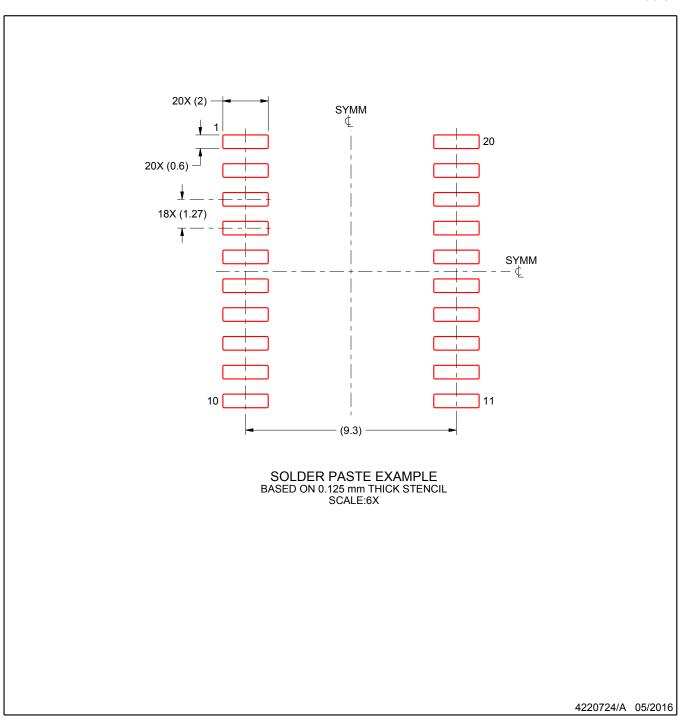
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



### **MECHANICAL DATA**

### NS (R-PDSO-G\*\*)

## 14-PINS SHOWN

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



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